Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/590,248	BAYLOFF ET AL.
Examiner	Art Unit
Bao-Thuy L. Nguyen	1641

SEARCHED				
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422	58-61	12/31/2007	вти	
422	102			
436	518, 514			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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(INCLUDING S	RCH NOT SEARCH	STRATEGY)
		DATE	EXMR
EAST, Authors		12/31/2007	вти
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